

Notice of References Cited		Application/Control No. 10/582,010	Applicant(s)/Patent Under Reexamination RATKE ET AL.	
		Examiner Chun-Cheng Wang	Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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*	N	EP 1077097	02-2001	DE	Lorenz et al.	B22C 1/00, 9/10
	O					
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NON-PATENT DOCUMENTS

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